

Notice of References Cited	Application/Control No. 10/627,613	Applicant(s)/Patent Under Reexamination CHEN, YU-SHENG	
	Examiner Philip J. Sobutka	Art Unit 2684	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2005/0083794 A1	04-2005	Tagawa et al.	369/030.08
*	B	US-2003/0092433 A1	05-2003	Flannery, Michael R.	455/416
*	C	US-2003/0044654 a1	03-2003	Holt, Laurence E.	455/416x
*	D	US-2002/0173338 a1	11-2002	Neumann et al.	455/552.1
*	E	US-2002/0173344 a1	11-2002	Cupps et al.	455/566
*	F	US-6,405,027 b1	06-2002	Bell, John R.	455/416x
*	G	US-5,884,168 a	03-1999	Kolev et al.	455/551x
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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